

Notice of References Cited	Application/Control No. 10/577,400		Applicant(s)/Patent Under Reexamination CHIBA ET AL.	
	Examiner BACKHEAN TIV		Art Unit 2451	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,246,313	07-2007	Sung et al.	715/202
*	C	US-2004/0181550	09-2004	Warsta et al.	707/104.1
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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